Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/043,095	JUNG, SUK-JIN	
Examiner	Art Unit	
Jaison Joseph	2634	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	354	4/7/2005	IJ
375	149	4/7/2005	IJ
375	152	4/7/2005	JJ

TNI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u> </u>				

SEAR( (INCLUDING SE	CH NOTES EARCH STRATEGY	
	DATE	EXMR
Inventor Search	4/7/2005	JJ
East	4/7/2005	IJ
IEEE Xplore	4/8/2005	IJ
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